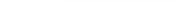


Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/621,450	OHISHI ET AL.
	Examiner	Art Unit
	LECHI TRUONG	2194

**SEARCHED**

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**